



Silicon Photonics

Roel Baets

Ghent University – IMEC

roel.baets@ugent.be

www.photonics.intec.ugent.be

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Acknowledgements

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- The European Space Agency
- The Belgian IAP-PHOTON network
- The Flemish Institute for the industrial advancement of Scientific and Technological Research (IWT)
- The Flemish Fund for Scientific Research (FWO-Vlaanderen)
- The Silicon Process division at IMEC
- The P-line at IMEC



Outline

Silicon Photonics: why and how?

Passive wavelength routers in Silicon

Active photonic functions in Silicon

Silicon photonics: what for?

Silicon Photonics: why and how?

Why?

- **Functionality + performance**
- **Technology**
- **Cost**

How?

- **Wafer-level fabrication**
- **Packaging**

Silicon photonics

Functionality and performance:

spectacular breakthroughs in last 2 years

- low loss waveguides (IMEC, NTT, IBM...)
- compact wavelength routers (IMEC...)
- ultra-compact microcavities (U. Kyoto...)
- >>10 Gb/s receivers (LETI...)
- 10 Gb/s modulators (INTEL, Luxtera...)
- Raman Silicon laser (INTEL...)
- (velocity tunable) slow light (IBM...)
- all-optical switching + λ -conversion (NICT+IMEC...)
- integration with CMOS (Luxtera...)

Objectives

- Si nanophotonics with CMOS processes
- Application-specific EPIC
- New photonic devices in Si
(lasers, wavelength converters, amplifiers, ...)

Partners

- MIT
- Luxtera
- Sun
- Freescale

Budget: 12M\$

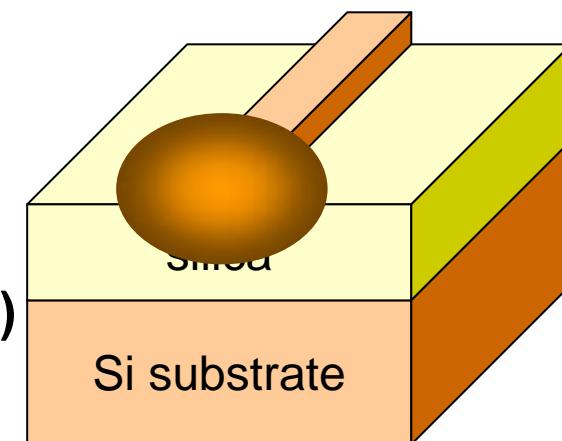
www.darpa.mil/mto/epic

Photonics Research Group

Nanophotonic waveguides

Silicon on Insulator

- Transparent at telecom wavelengths (1.55 μm and 1.3 μm)
- High refractive index contrast
 - in-plane: 3.45(Si) to 1.0 (air)
 - out-of-plane: 3.45 (Si) to 1.45 (SiO_2)
- Typical dimensions:
 - Thickness: 200 nm
 - Width: 500 nm
 - Required accuracy: 1-10 nm
- Compatible with CMOS processes



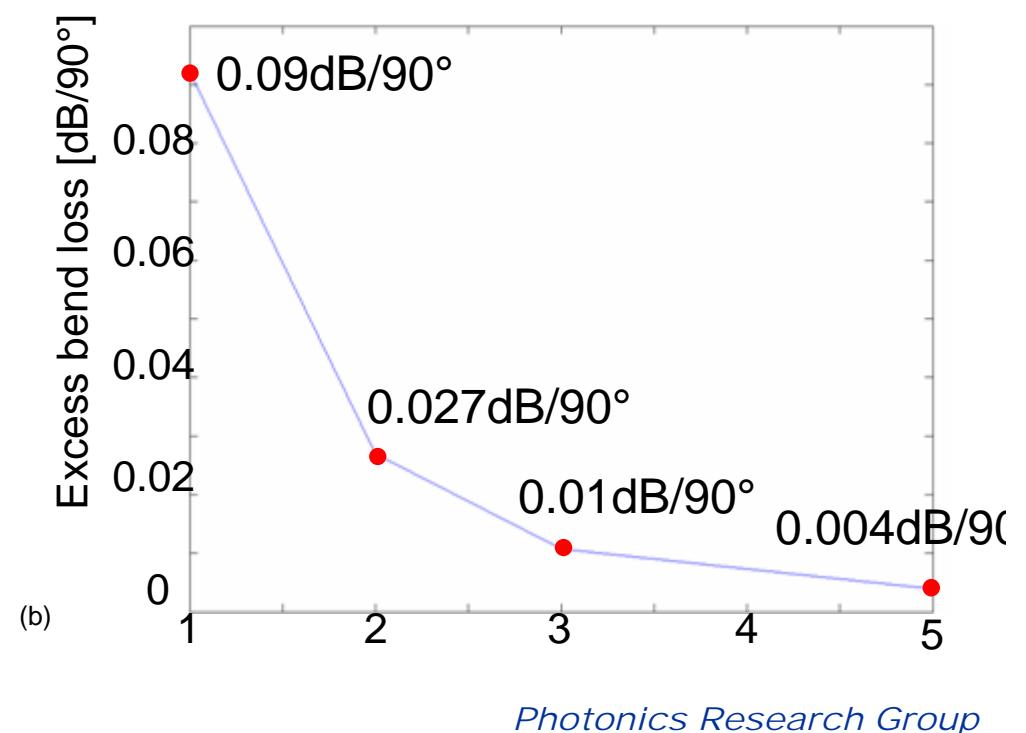
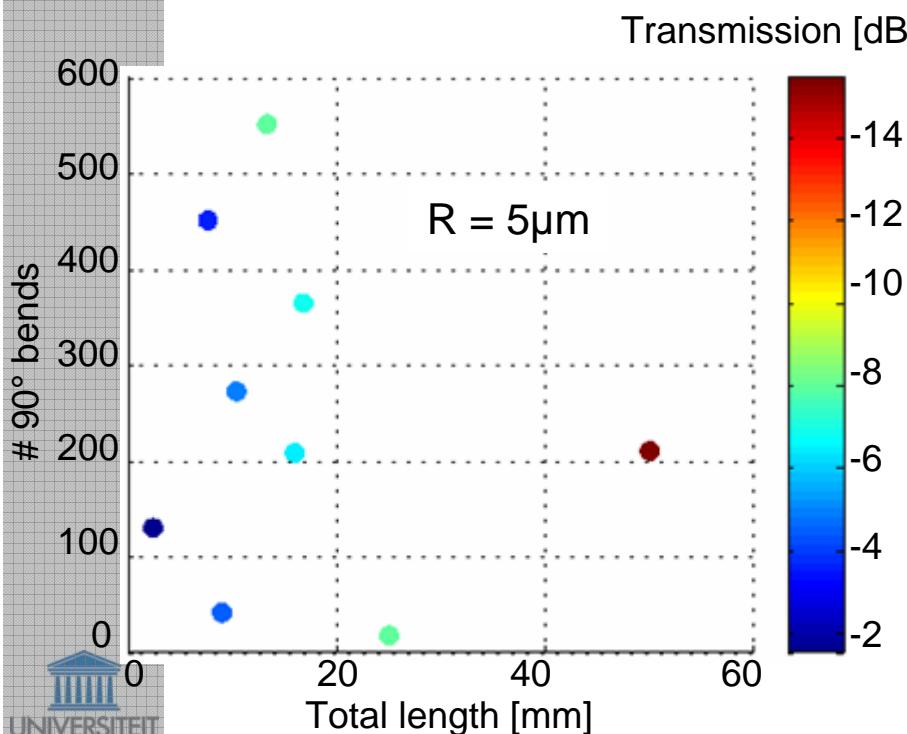
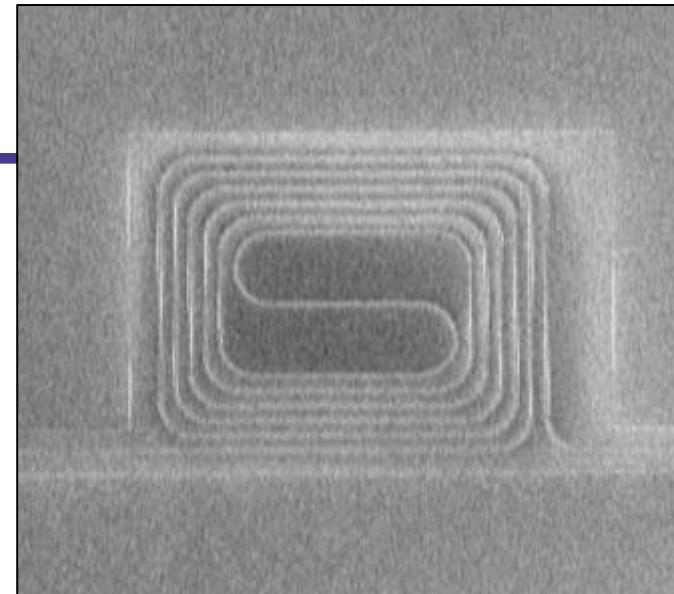
SOI-nanophotonic wires

Group	Date	h [nm]	w [nm]	loss [dB/cm]	BOX [um]	top clad	Fab.
IMEC	Apr. '04	220	500	2.4	1	no	DUV
IBM	Apr. '04	220	445	3.6	2	no	EBeam
Cornell	Aug. '03	270	470	5.0	3	no	EBeam
NTT	Feb. '05	300 200	300 400	7.8 2.8	3	yes	EBeam
Yokohama	Dec. '02	320	400	105.0	1	no	EBeam
MIT	Dec. '01	200	500	32.0	1	yes	G-line
LETI / LPM	Apr. '05	300 200	300 500	15.0 5.0	1	yes	DUV
Columbia	Oct. 03	260	600	110.0	1	yes	EBeam
NEC	Oct. '04	300	300	19.0	1	yes	EBeam

Waveguide bends

Spirals

- Long waveguides (up to 50mm)
- Many bends (up to 560)



Bends

Group	h [nm]	w [nm]	Radius [um]	Loss [dB/90]	Note
IBM	220	445	1.0	0.086	20 bends
			2.0	0.013	
			5.0	0	
IMEC	220	500	1.0	0.09	> 500 bends
			2.0	0.027	
			5.0	0.004	
NTT	300	300	2.0	0.46	24 bends
			3.0	0.17	
Yokohama	320	400	1.0	3	
MIT	200	500	1.0	0.5	12 bends poly-Si
			resonant	0.3	
LETI/LPM	220	500	2.0	0.15	40
			5.0	0.05	
Columbia	340	400	resonant	1.3	2 bends

Nano ?

- Feature size: a few 100nm
- Required accuracy of features:
- For wavelength-dependent struc-

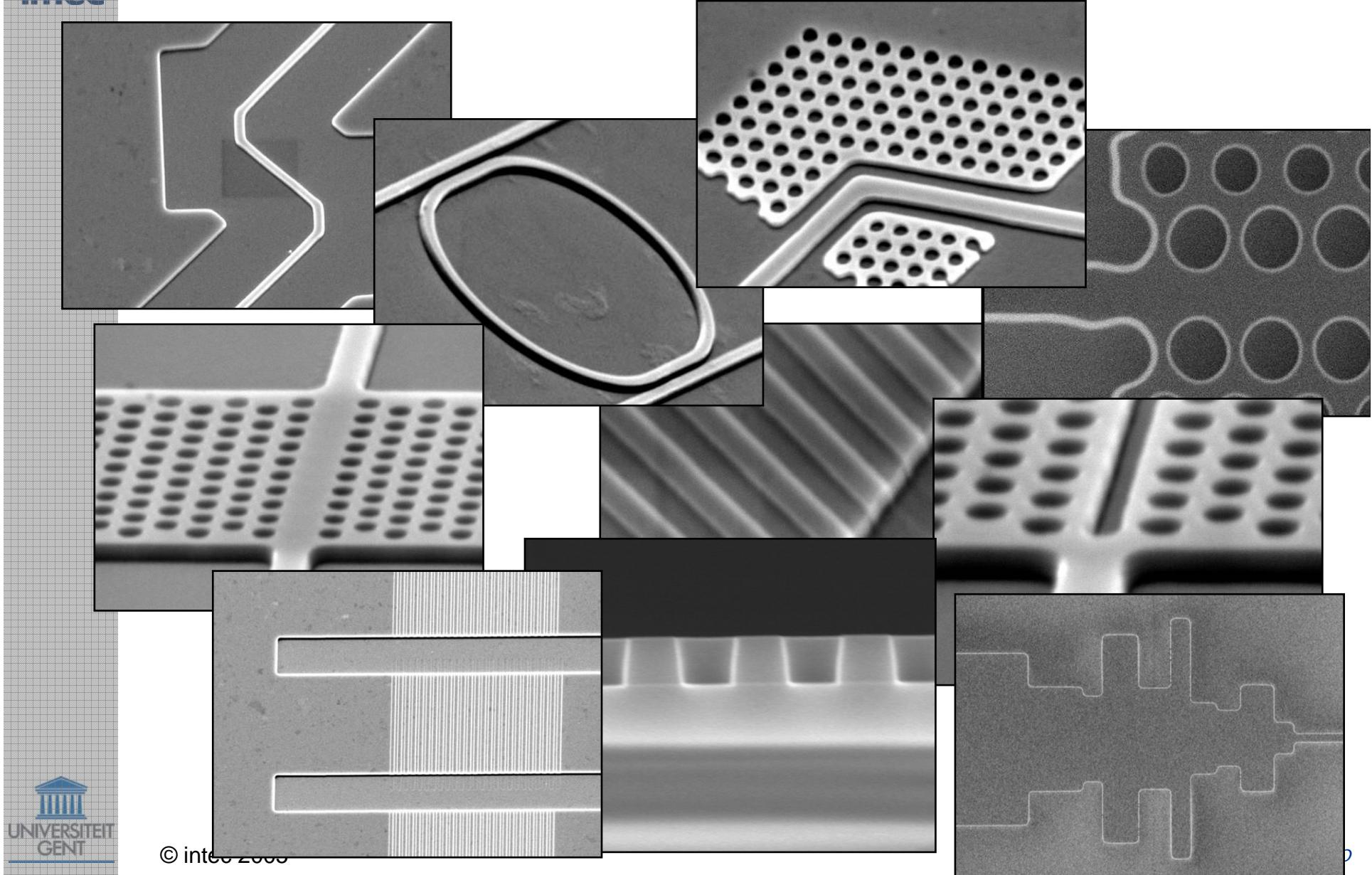


nm-scale wavelength accuracy : O(1nm) dimensional accuracy !

Fabrication ?

- Classical optical lithography → too low resolution
- E-beam lithography, focused ion beam → too slow
- Deep UV lithography (used for CMOS)
 - 248nm, 193nm
 - Fabrication in IMEC CMOS-pilot line
 - 200mm wafers

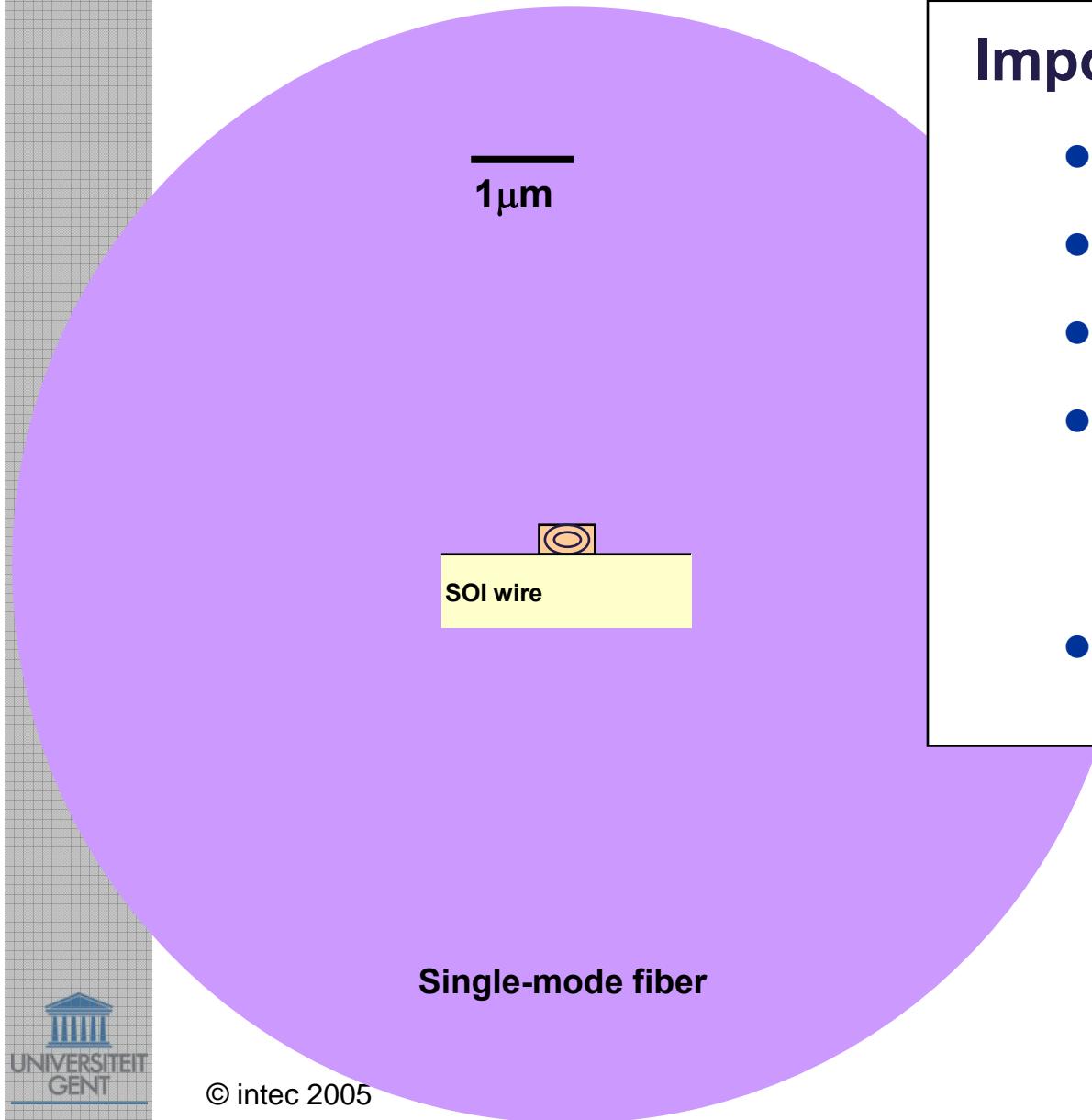
Fabricated Structures



Low cost

- **Wafer-scale fabrication on large wafers with high yield**
- **Wafer-scale testing**
- **Low cost packaging**

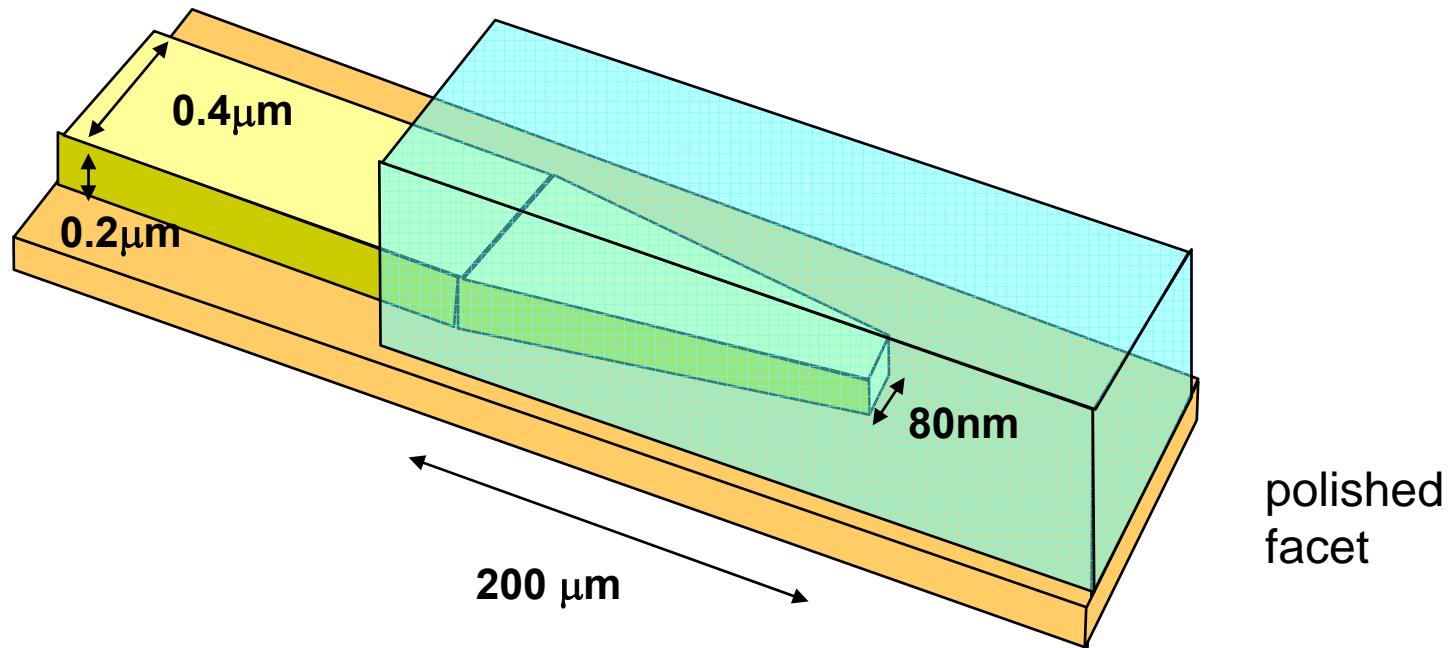
Coupling into SOI nanophotonics



Important:

- Low loss
- Large bandwidth
- Coupling tolerance
- Fabrication
 - Limited extra processing
 - Tolerant to fabrication
- Polarization

Coupling to fiber – Inverse taper

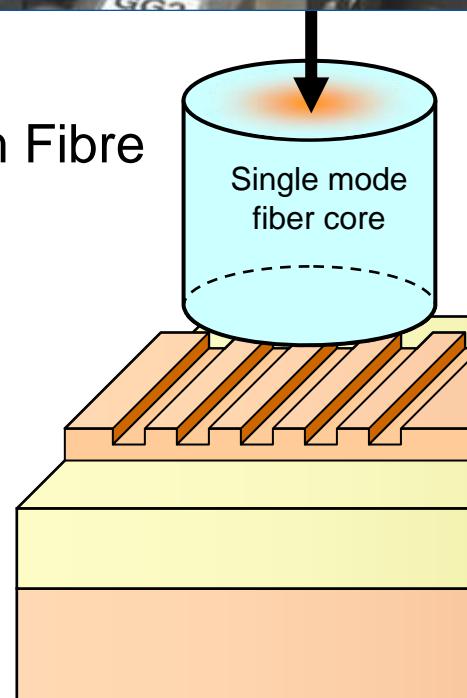


Group	h [nm]	w [nm]	L [um]	tip width [nm]	Cladding Material	Cladd ing Size	Loss
IBM (e-beam)	220	445	150.0	75.0	Polymer	2x2	< 1dB
Cornell (e-b)	270	470	40.0	100.0	SiO2	?x?	< 4dB
IMEC(DUV)	200	500	175.0	175.0	Polymer	3x1.3	< 2dB
NTT (ebeam)	300	300	200.0	60.0	Polymer/Si3N4	3x3	0.8

Coupling to fiber – Grating coupler

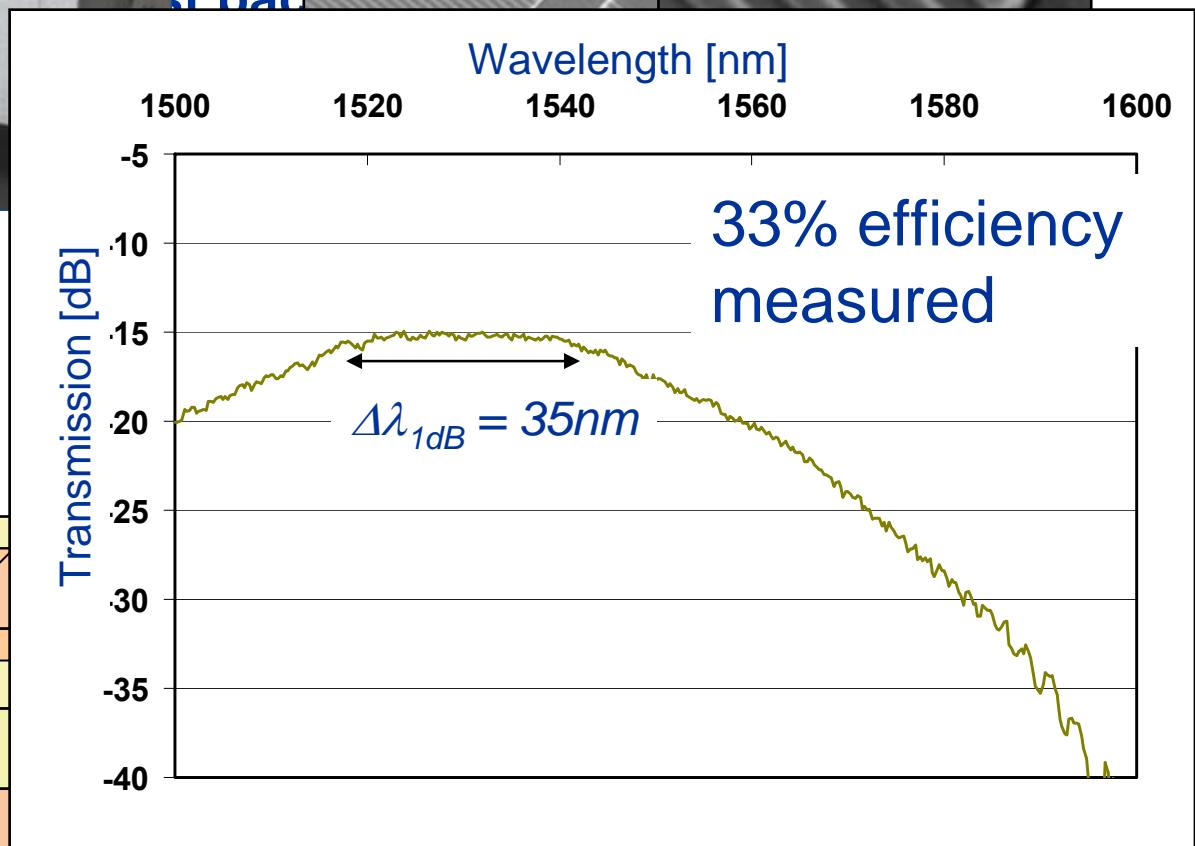
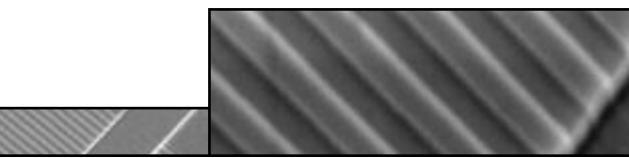


From Fibre



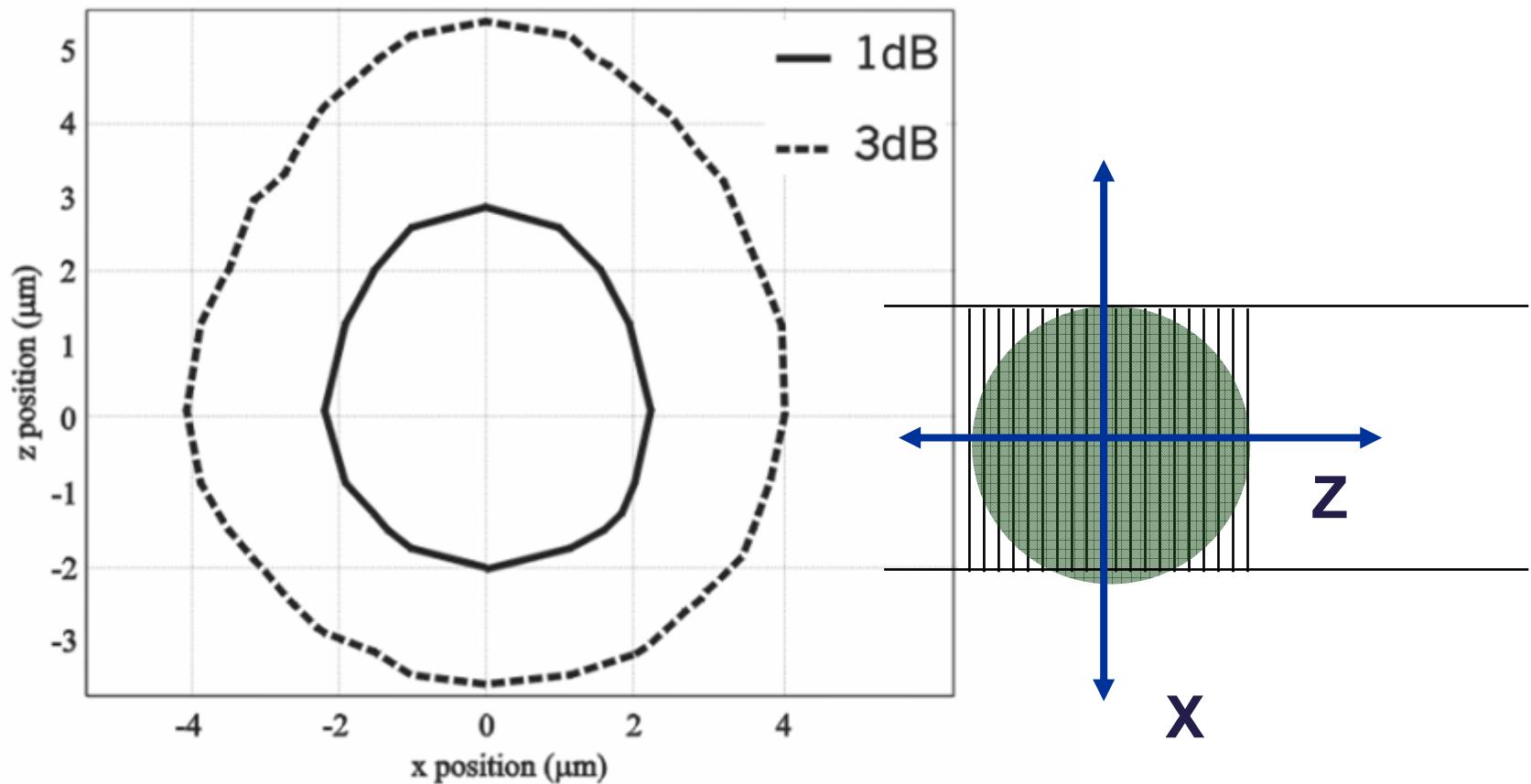
couplers

test pac



Alignment tolerances

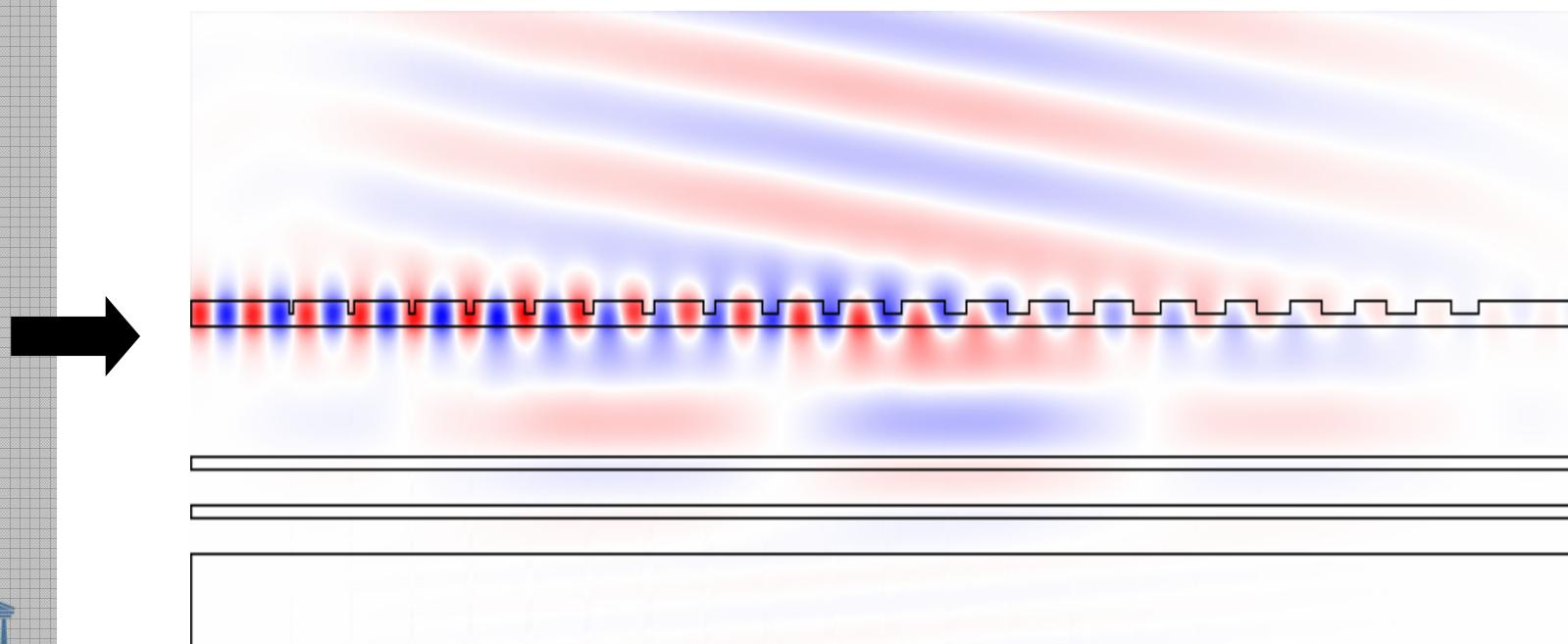
- good alignment tolerances
- measurement of P/P_{\max} versus fiber position



Coupling to fiber – Grating coupler

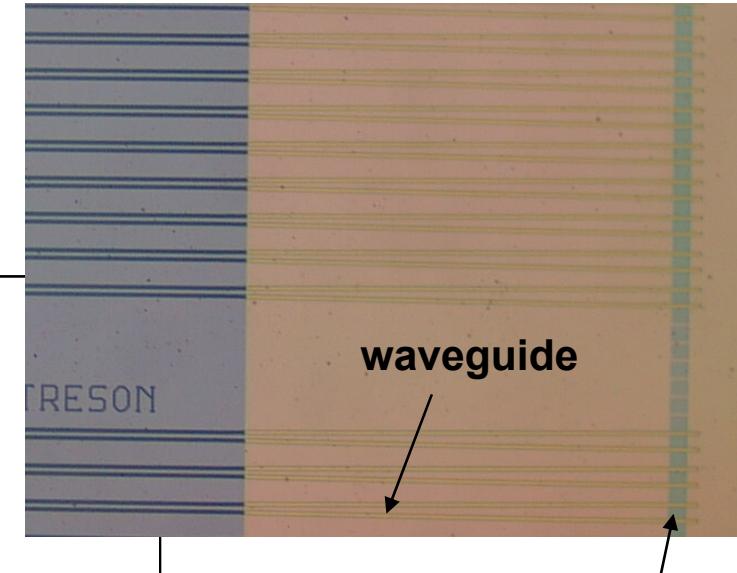
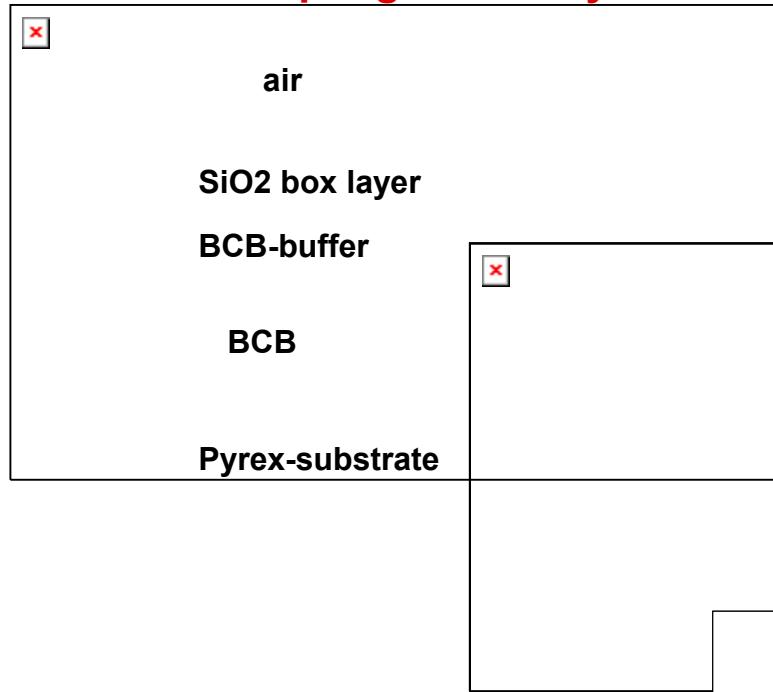
Improved design

- Apodise grating → efficiency 63%
- Add bottom reflector → efficiency over 90%

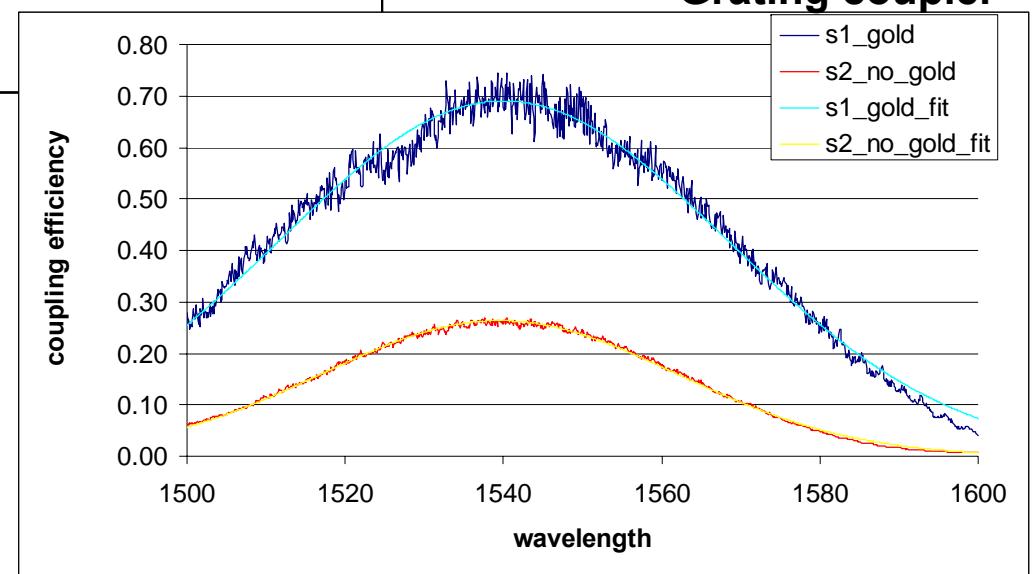


Bonded SOI-coupler with gold bottom mirror

Theoretical coupling efficiency 78%



Measured coupling efficiency:
69% (1.5 dB loss)

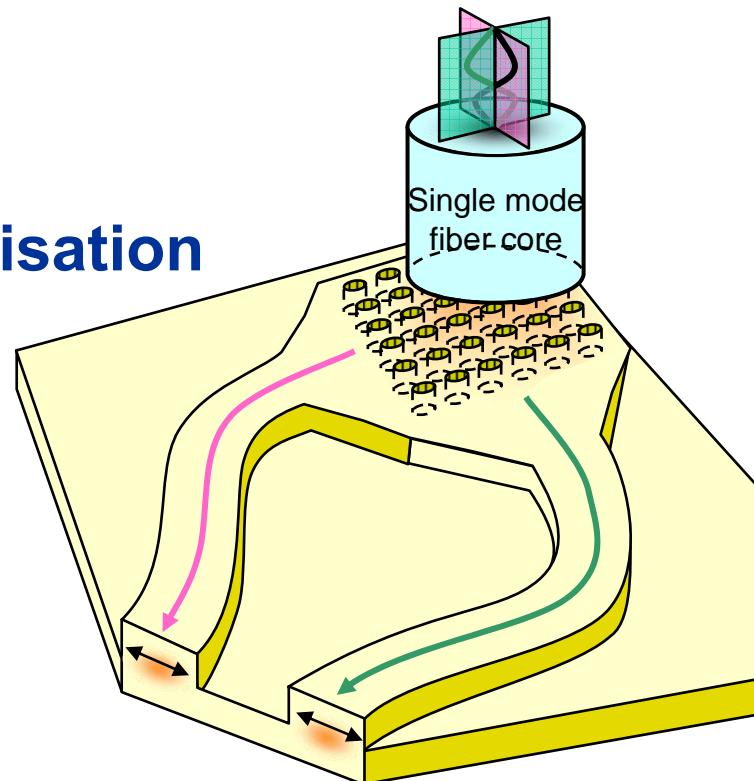


Polarisation problem

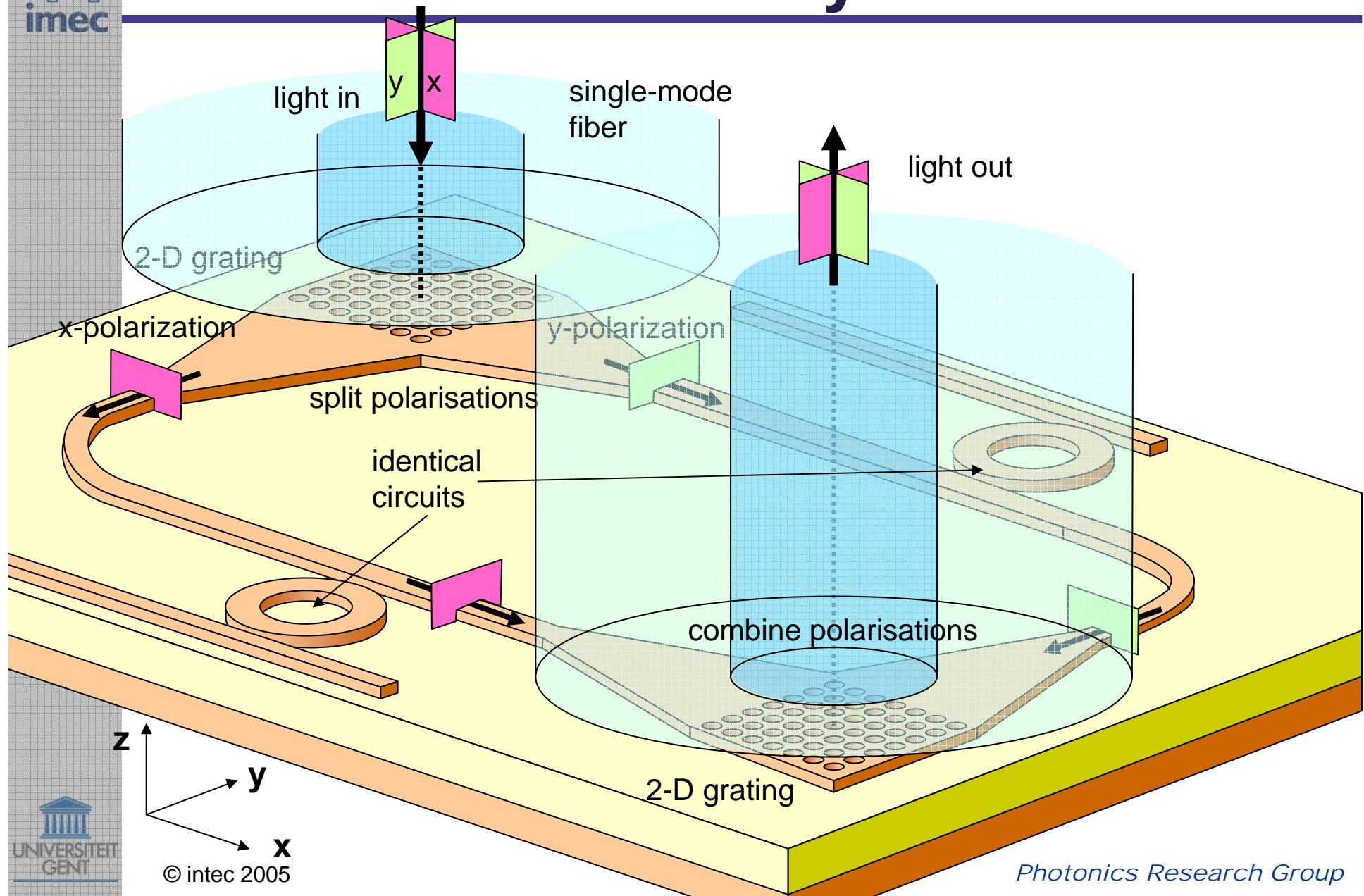
Problem: nanophotonic circuits are highly polarisation dependent

Our solution:

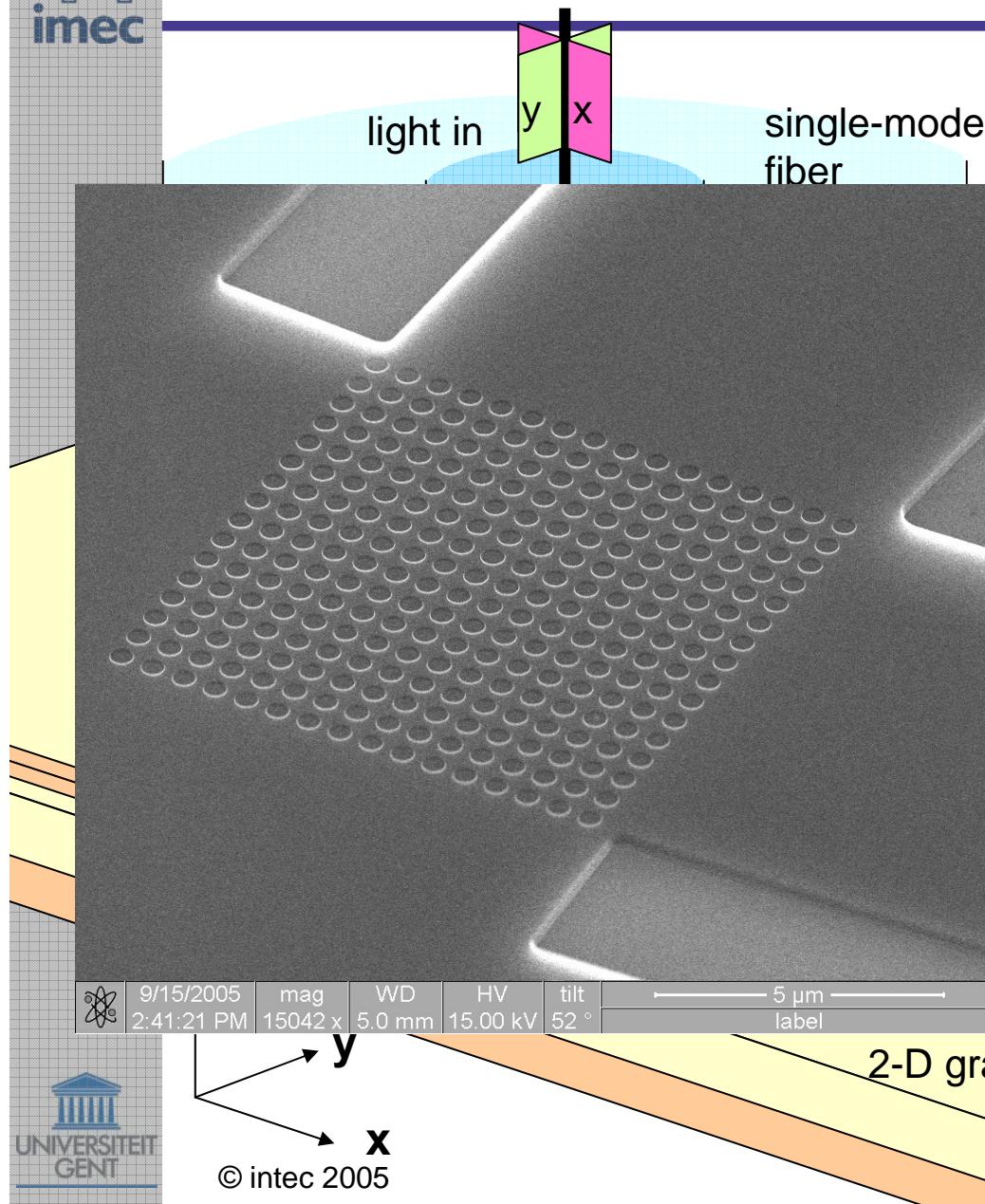
- **2D grating**
- **Couples each fiber polarisation in its own waveguide**
- **In the waveguides the polarisation is the same (TE)**
- **Allows for polarisation diversity approach**



Polarisation Diversity Circuit



Polarisation Diversity Circuit



Results 2D-coupler:

- 20 % efficiency
- 1dB bandwidth ~ 35 nm
- Extinction ratio > 18 dB

Outline

Silicon Photonics: why and how?

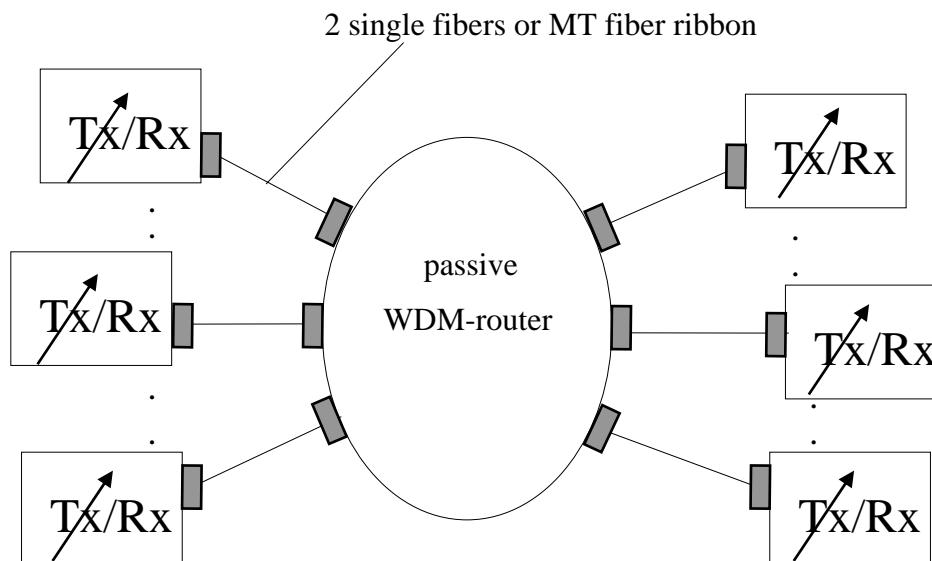
Passive wavelength routers in Silicon

Active photonic functions in Silicon

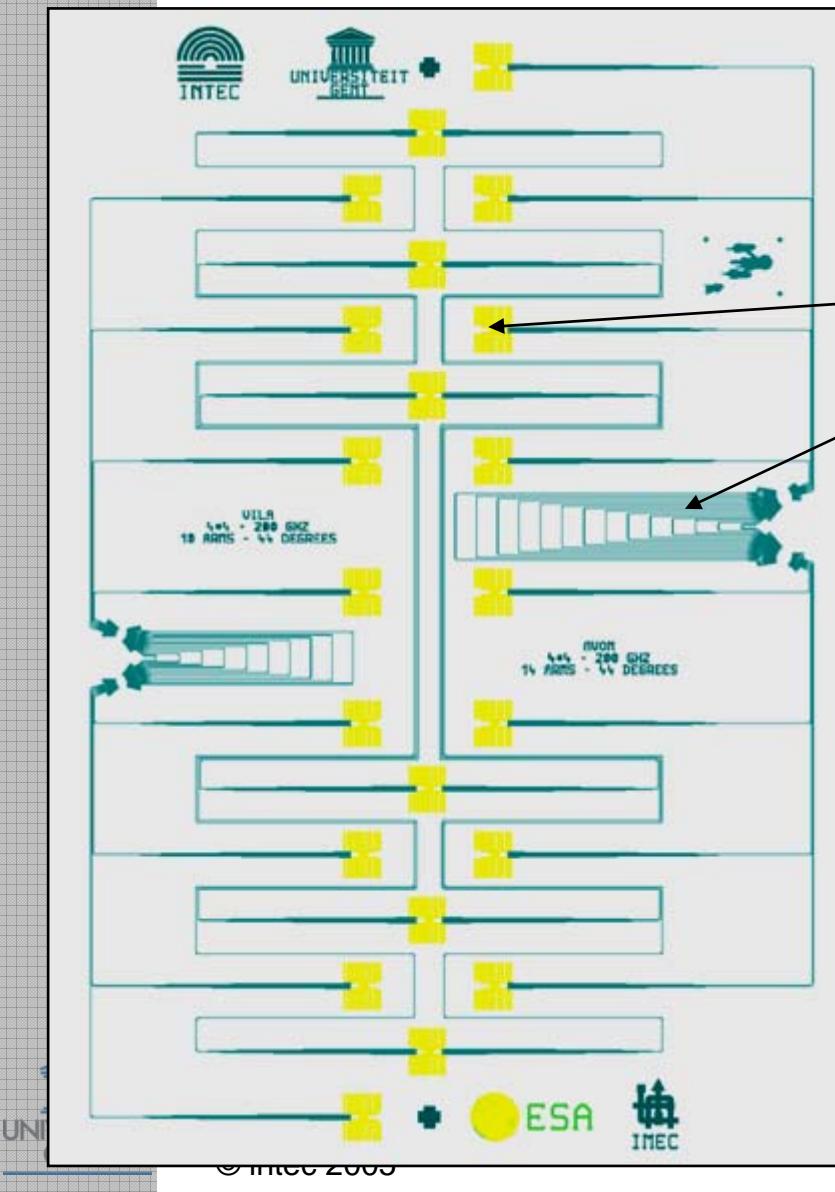
Silicon photonics: what for?

WDM switched optical backplane

- **routing functionality (w/o switches):** passive λ -based routing using tunable lasers
- Switching speed determined by tuning speed and by burst-mode receivers

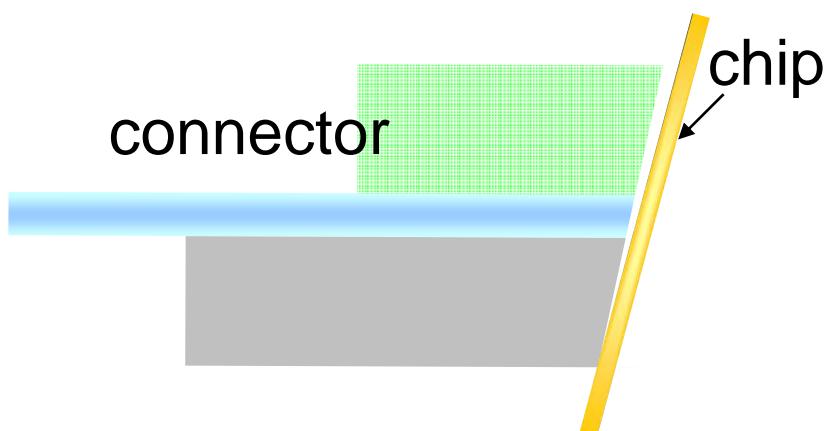


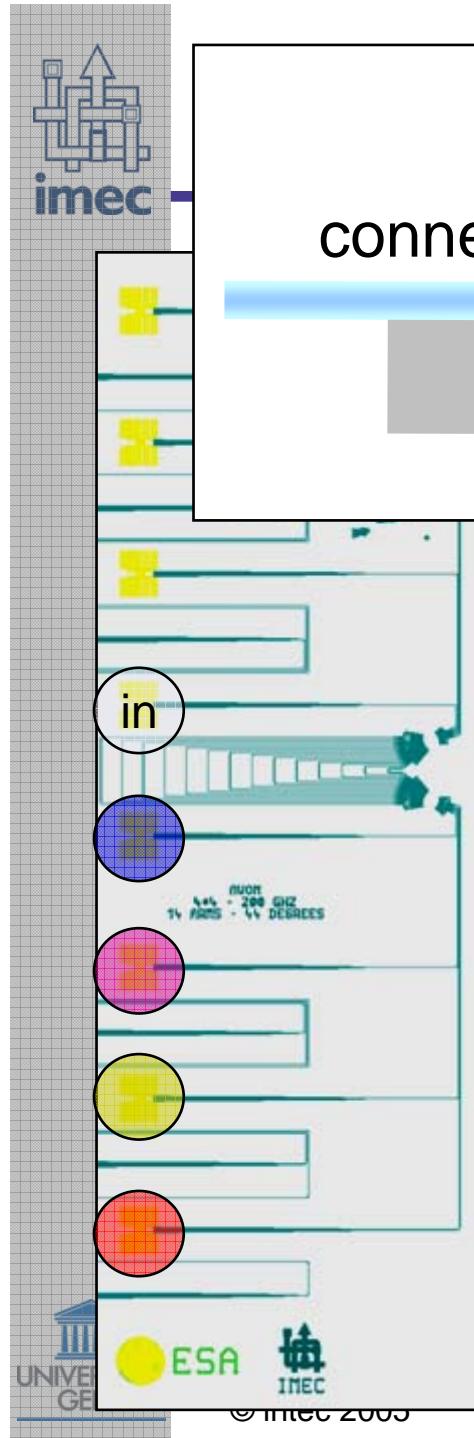
SOI wavelength router



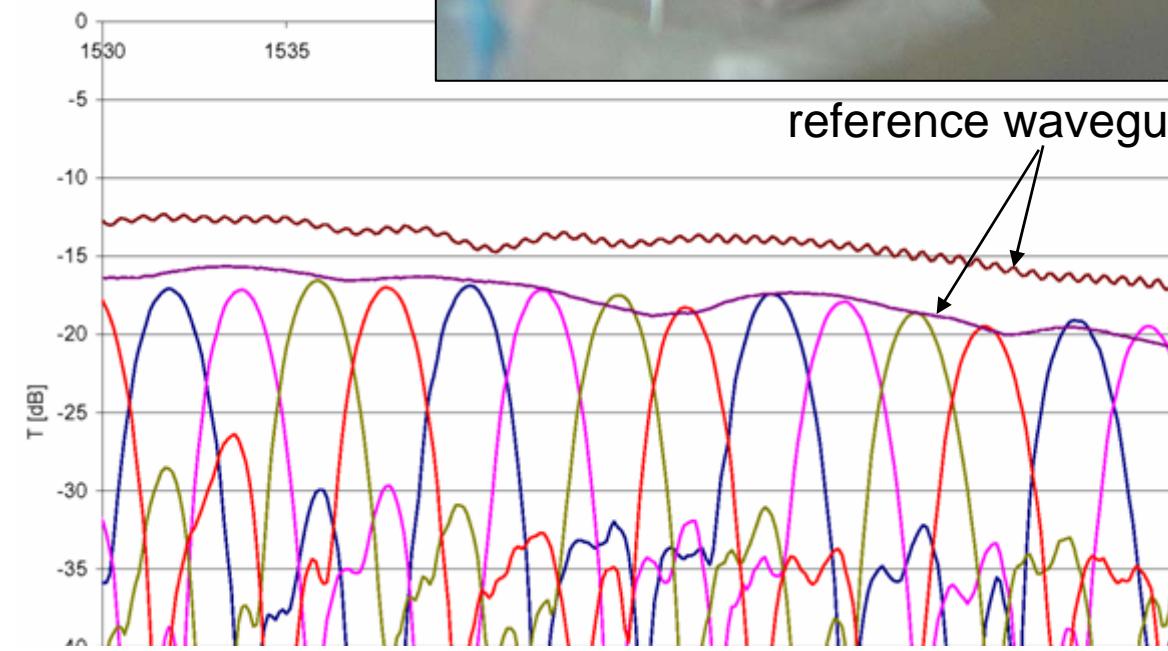
4 x 4 wavelength router

- Commercial connector with 8 fibers
- Vertical fiber couplers
- 4 x 4 AWG
- 200 GHz channel spacing





- shallow star coupler
- 3.5dB device insertion loss (coupler), -12 to -15 dB



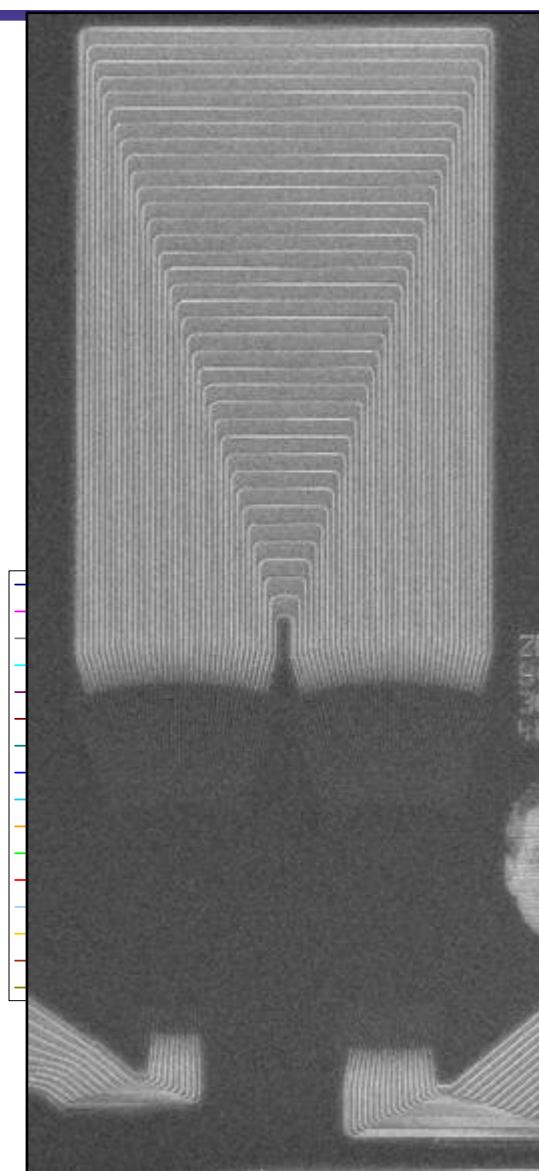
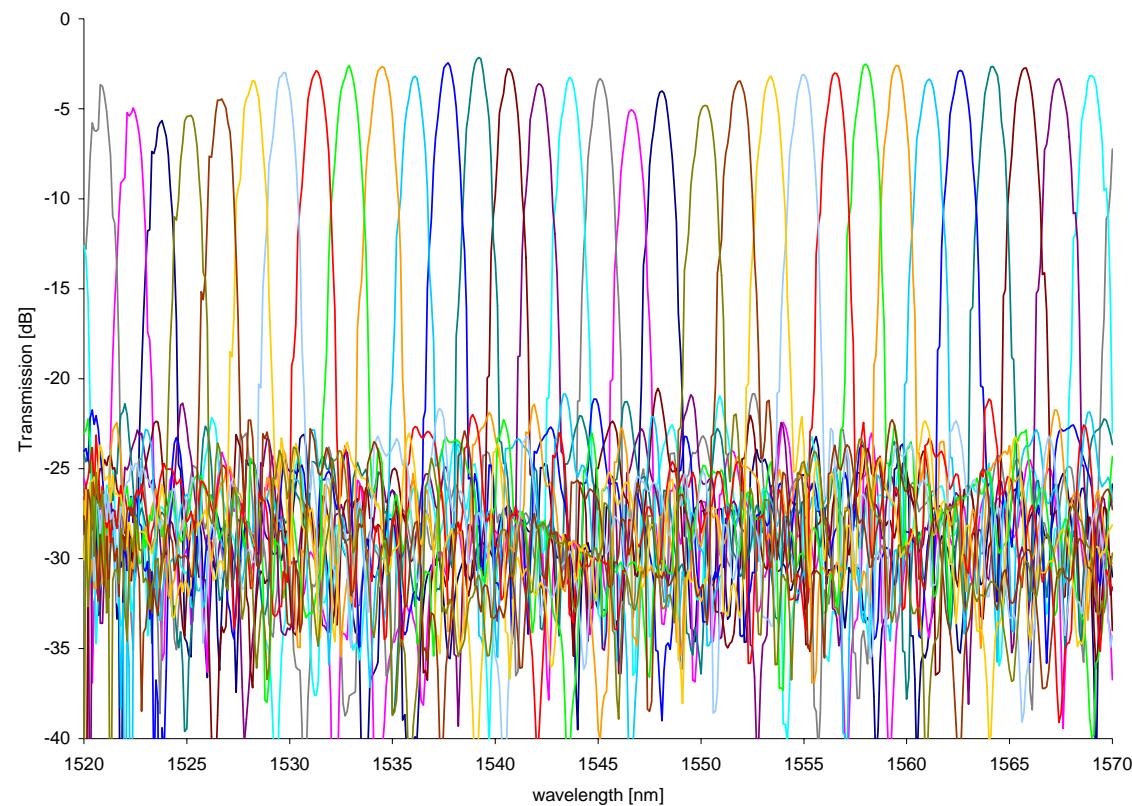
AWG

100μm

16-channel AWG, 200GHz

200μm x 500μm area

- **-3dB insertion loss**
- **-15dB to -20dB crosstalk**



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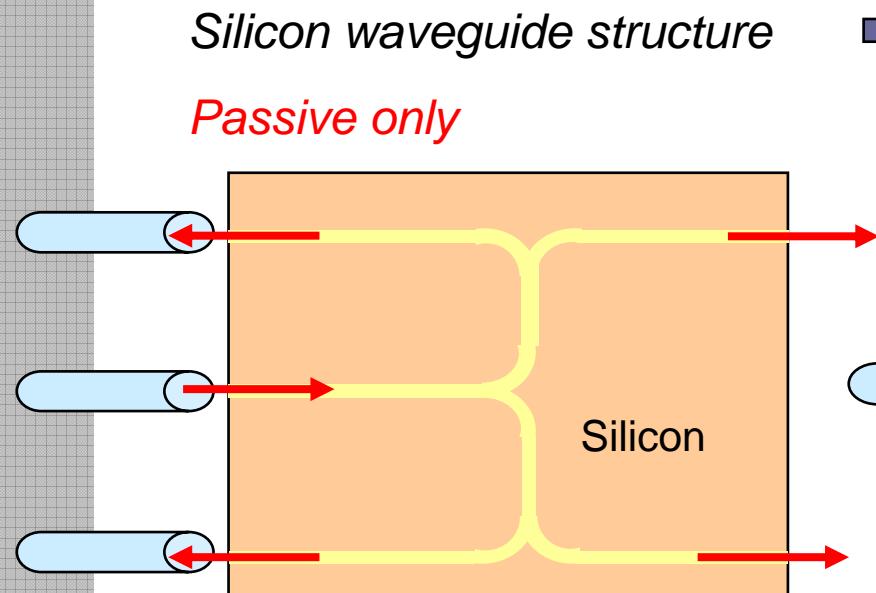
Silicon photonics: what for?

Active photonic functions

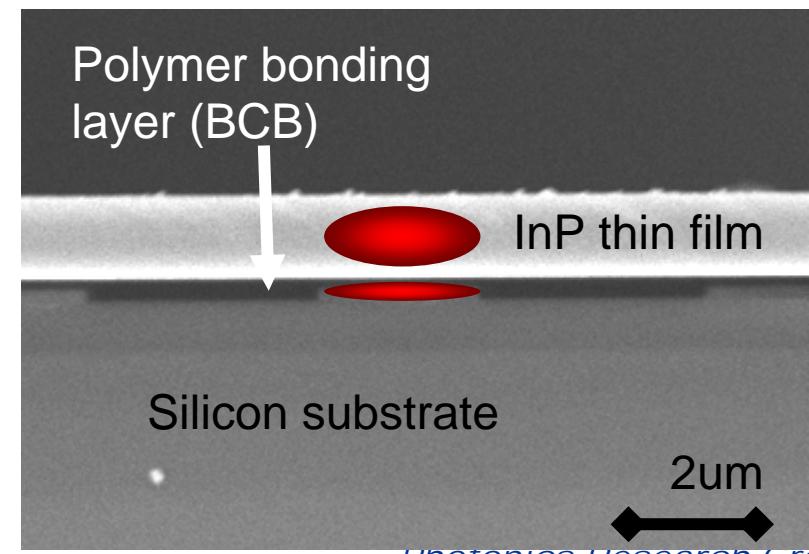
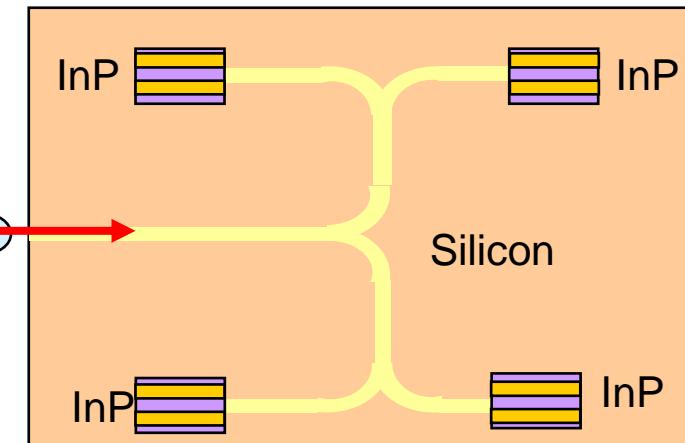
The options for modulation, switching, tuning at high speed:

- all Silicon approach
 - carrier density based optical effects + electric field induced carrier sweep away
 - All-optical approach using two-photon absorption
- Silicon + III-V-membrane integration
 - Using ultra-fast carrier lifetime in III-V
 - Also allowing light emission, gain, detection

Heterogeneous integration



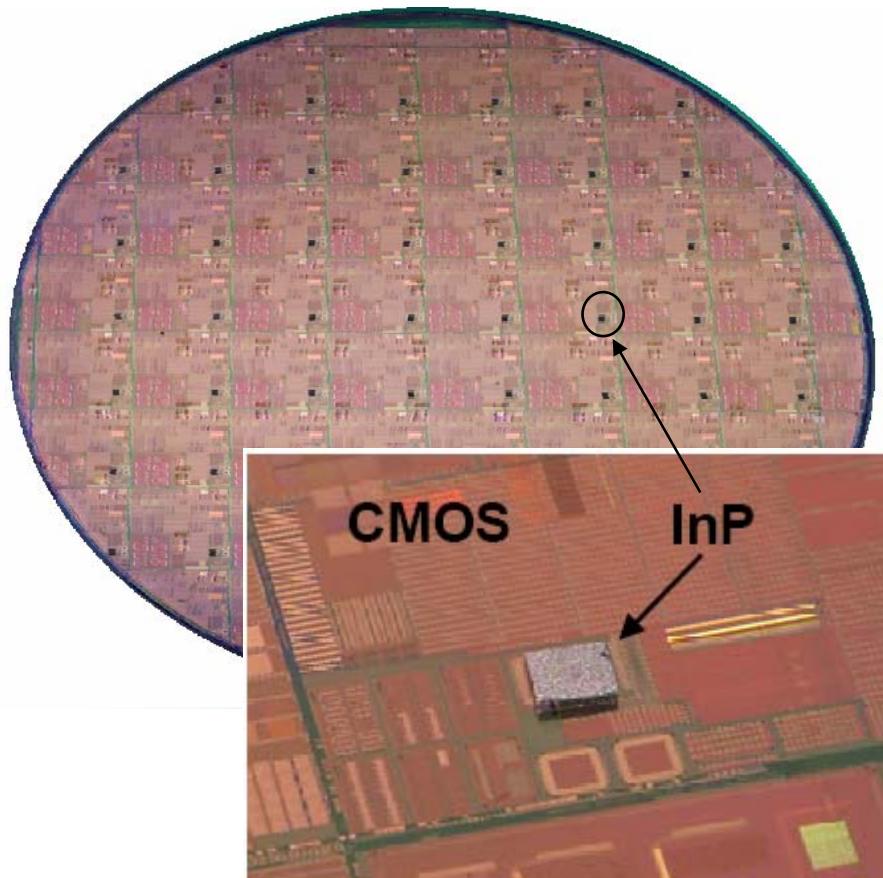
Heterogeneous circuit
Active + passive



Die-to-wafer bonding

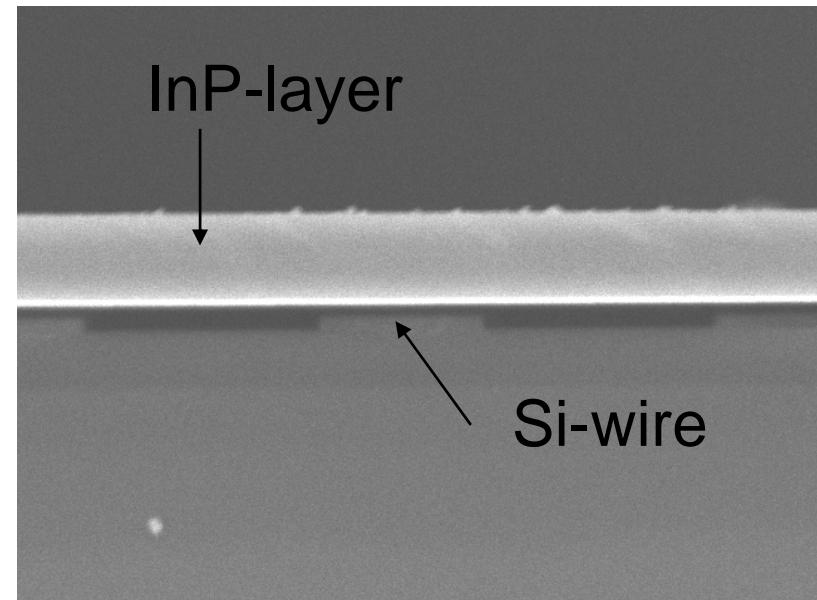
Molecular bonding

- InP on SOI-waveguides on CMOS demonstrated (LETI, TRACIT)



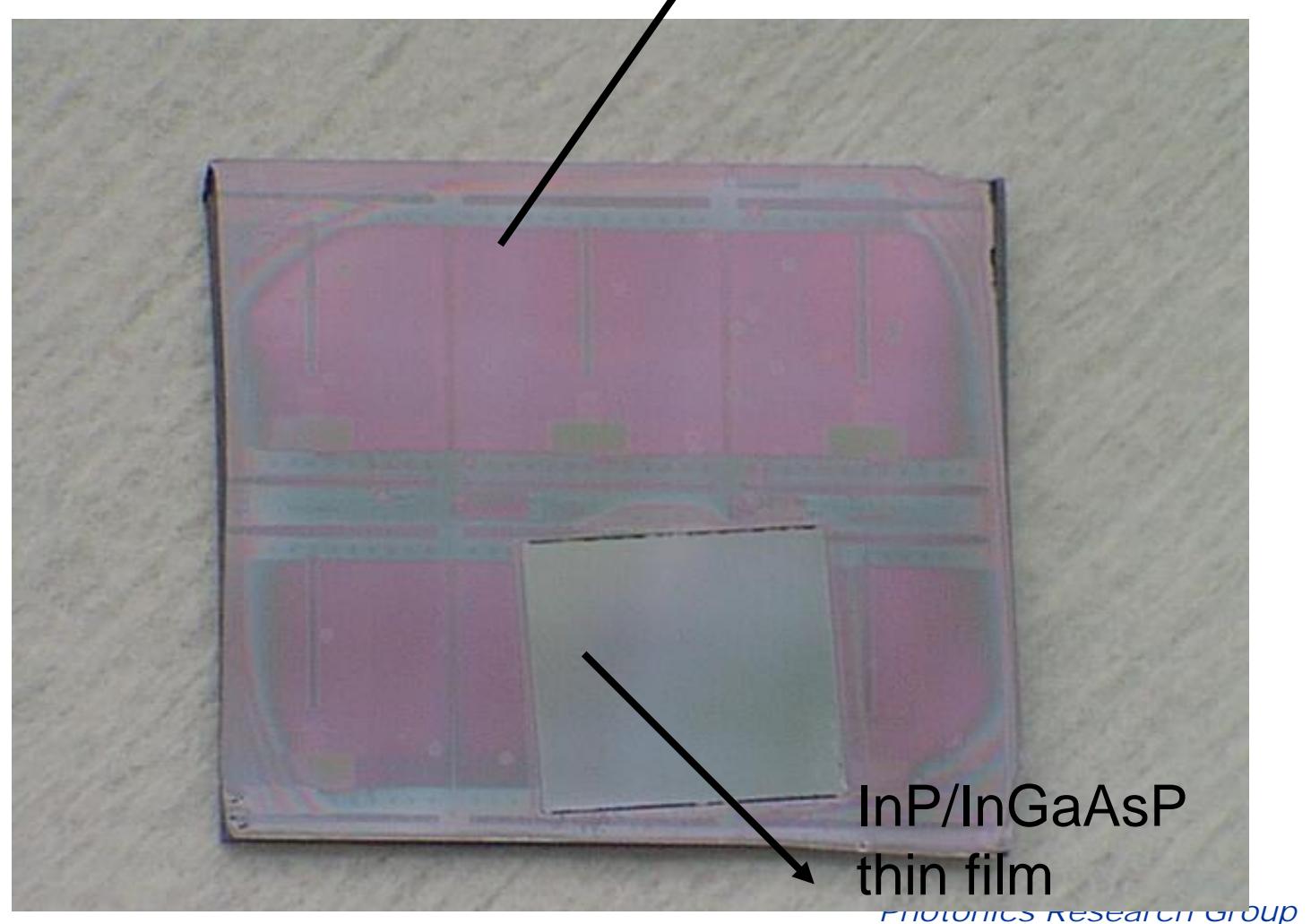
Polymer bonding

- Planarization and bonding in single step (IMEC)
- Ultra-thin bonding layers (sub 200nm demonstrated)

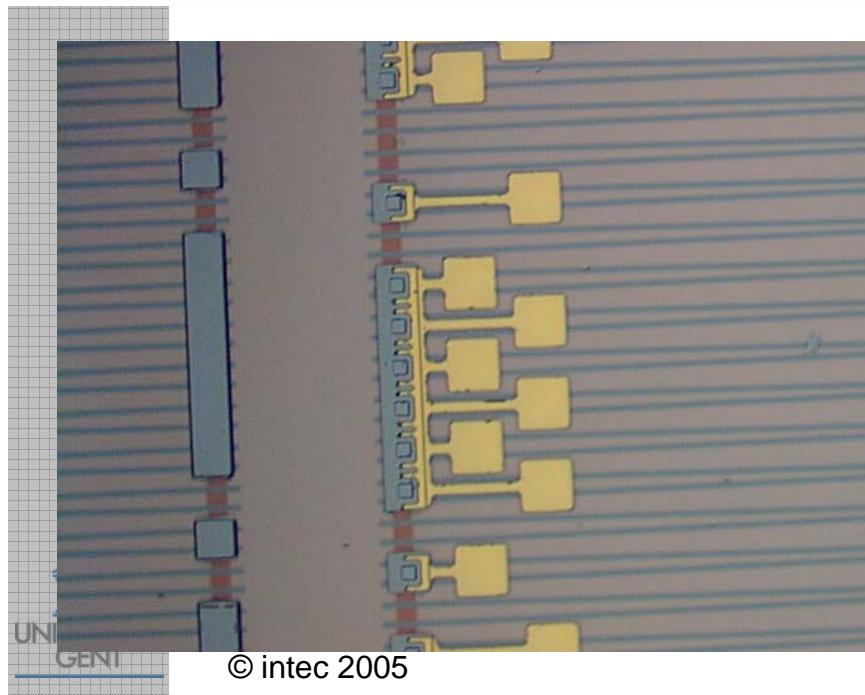
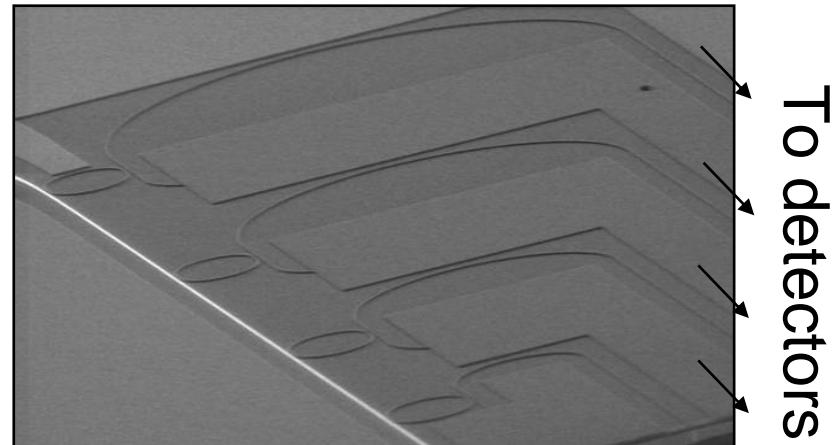
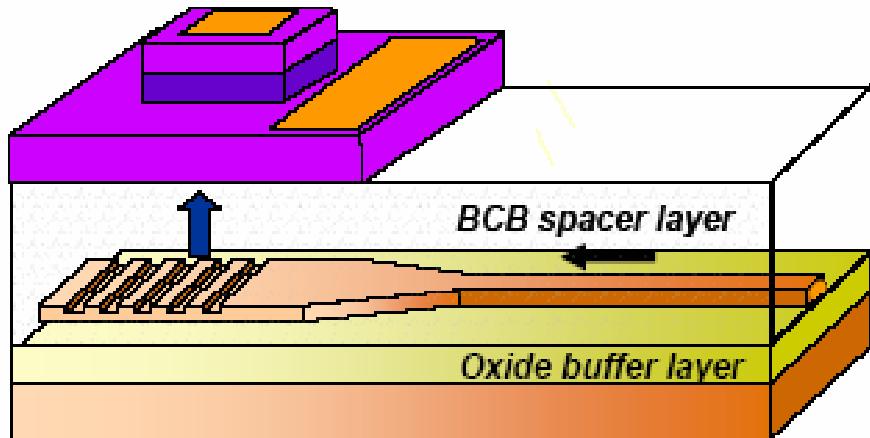


Die to wafer bonding technology

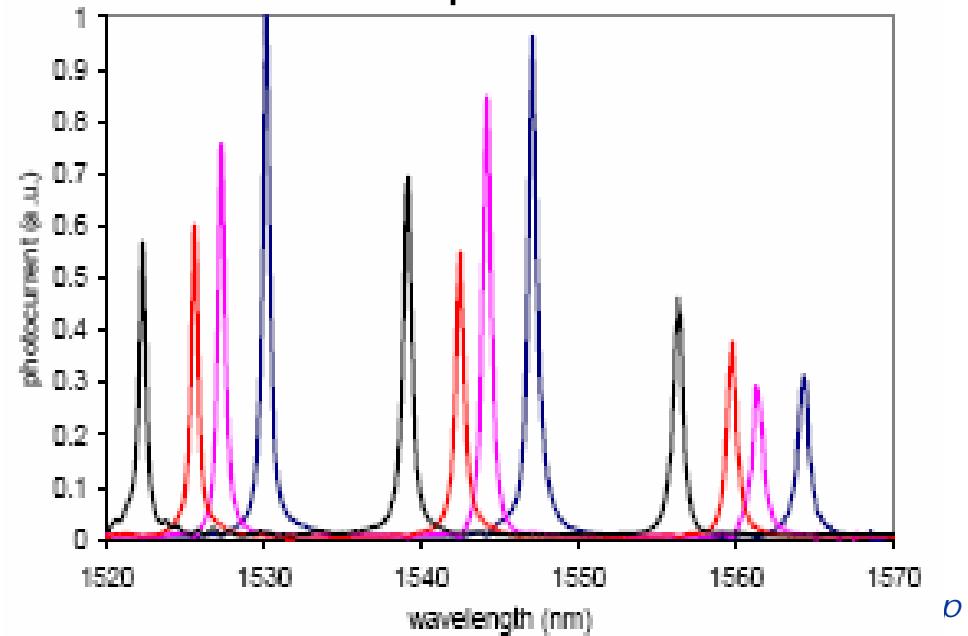
Good chemical resistance



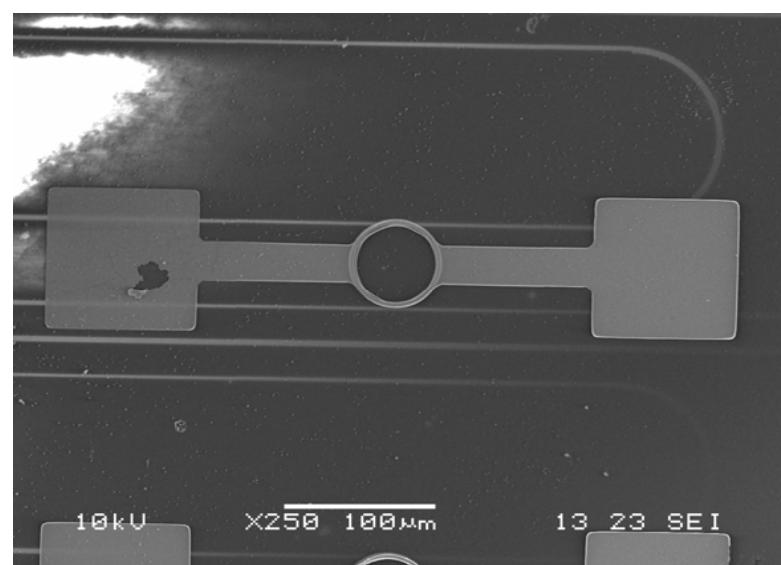
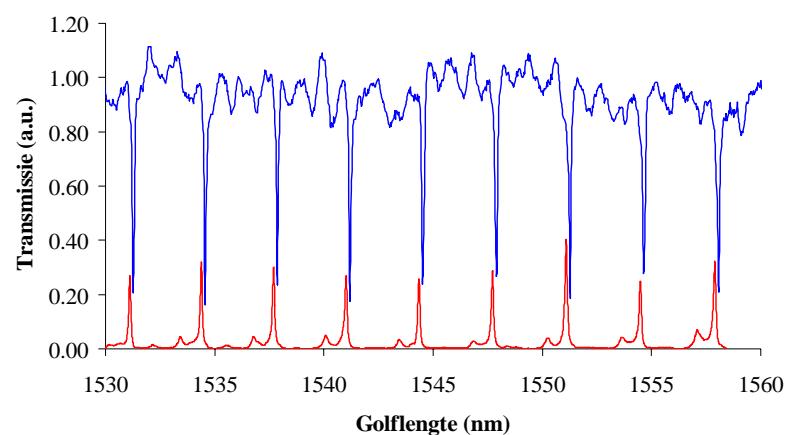
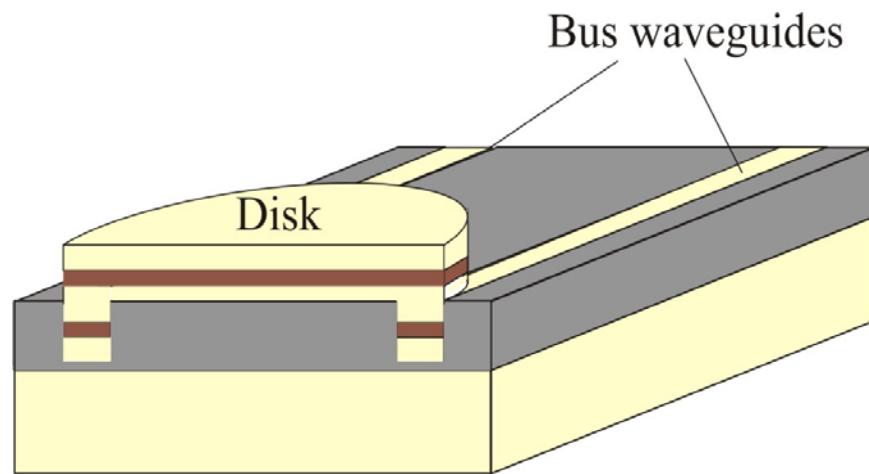
InGaAs Detectors on SOI



Measured response of 4 detectors

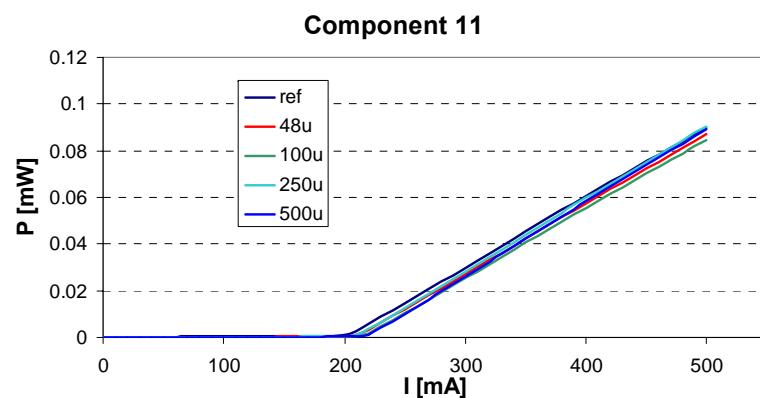


InP tunable ring resonators

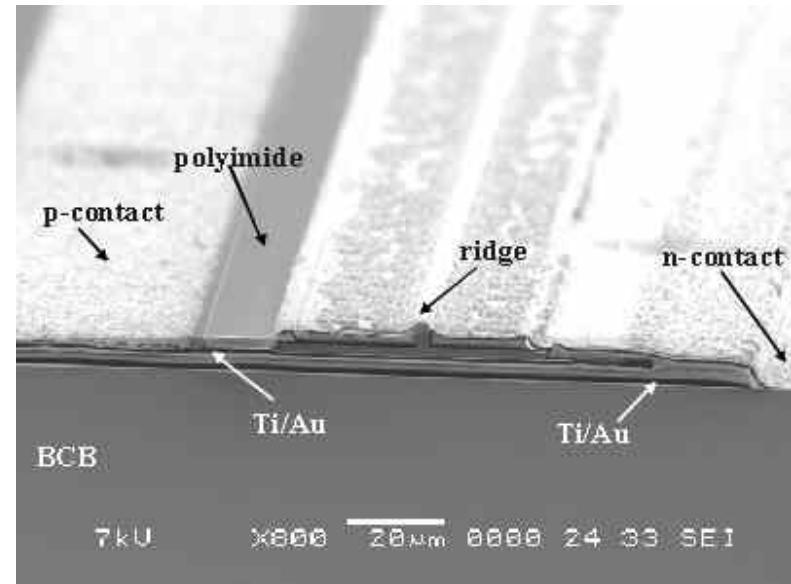


InP Fabry-Perot lasers

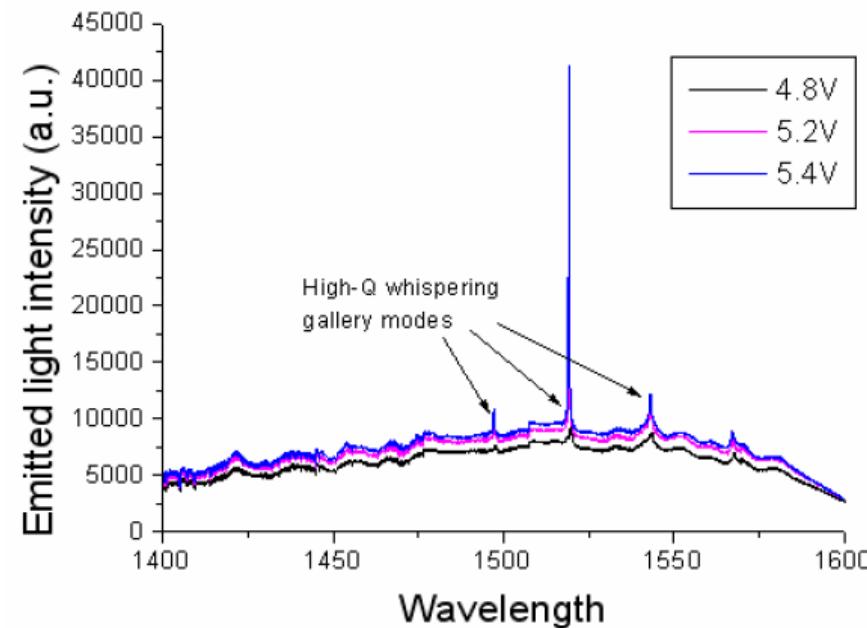
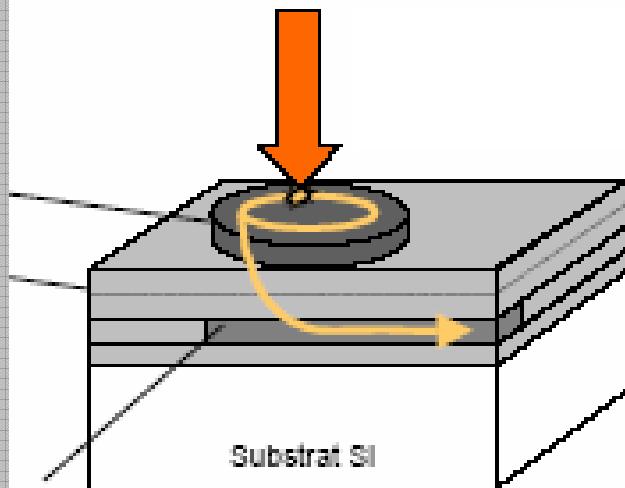
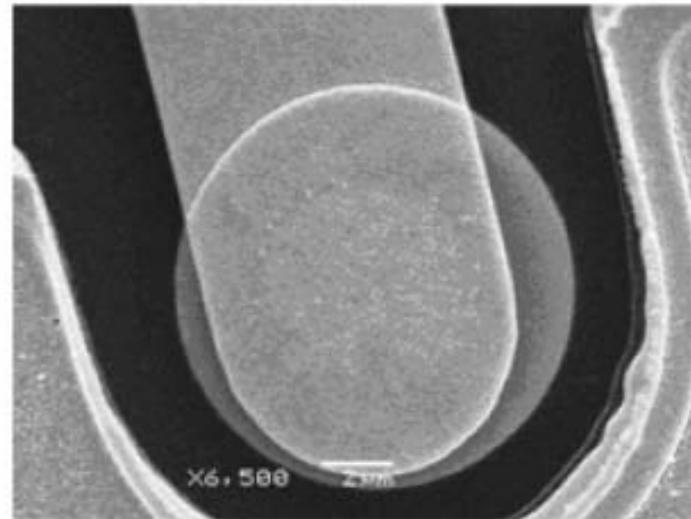
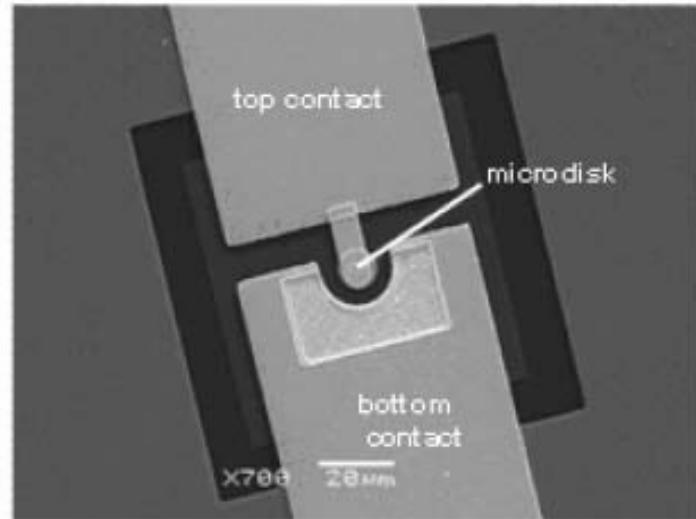
- Good functionality
- Damp-heat testing as proof of reliability of the BCB bonding process



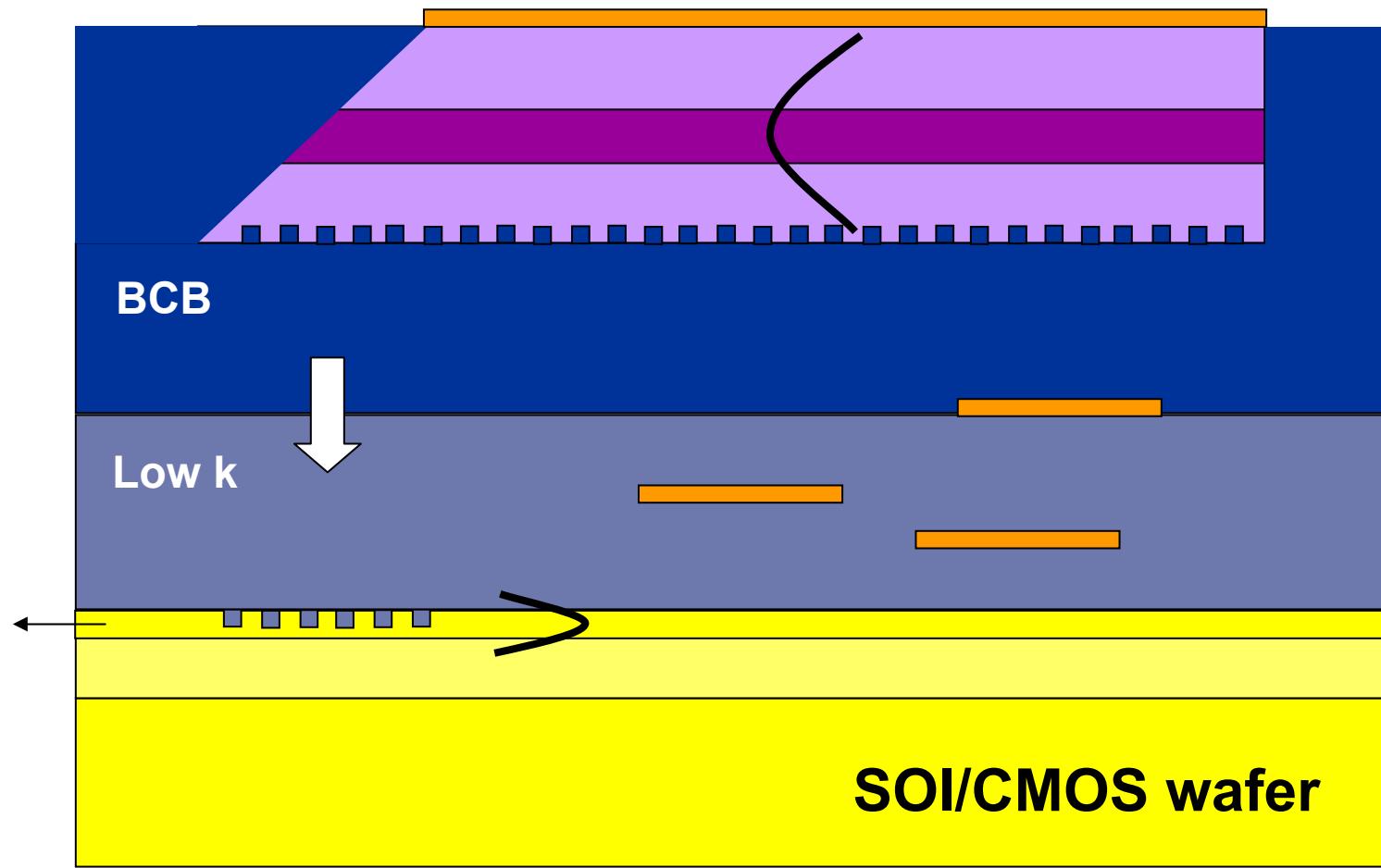
damp heat testing (85°C, 85% RH)
for 48, 100, 250 and 500 hours



Electrically pumped InP microdisk laser



InP DFB laser diode coupled to SOI



Outline

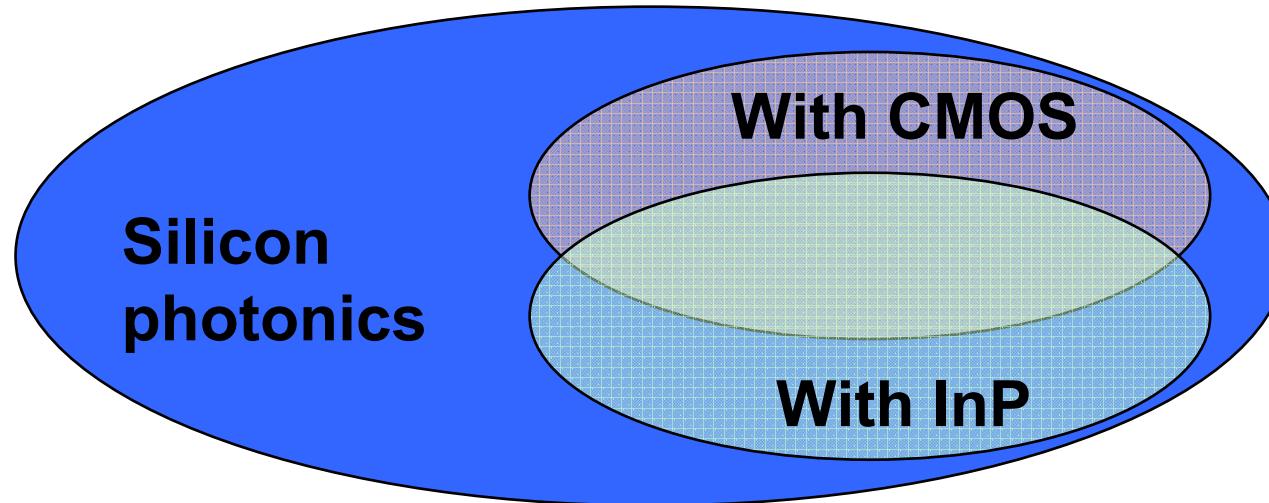
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Silicon photonics: what for?

Silicon photonics: what for?



- **WDM components**
- **switches for high speed backplanes**
- **single chip high speed low power transceivers**
- **on-chip optical interconnect**
- **sensors**
- **labs on a chip**

Conclusion

**Silicon photonics is a
generic technology
with a wide range of
high volume applications
for which the
industrial technology base
largely exists
today.**